1. General description

Planar Maximum Efficiency General Application (MEGA) Schottky barrier rectifier with an integrated guard ring for stress protection in a DSN0603-2 (SOD962-2) leadless ultra small Surface-Mounted Device (SMD) package.

2. Features and benefits

- Average forward current I_{F(AV)} ≤ 0.5 A
- Reverse voltage V_R ≤ 40 V
- Low forward voltage typ. V_F = 250 mV
- Low reverse current typ. I_R = 3 μA
- Ultra small and leadless SMD package
- Package height typ. 0.3 mm

3. Applications

- Low voltage rectification
- High efficiency DC-to-DC conversion
- Switch mode power supply
- Low power consumption applications
- Ultra high-speed switching
- LED backlight for mobile application

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{F(AV)}	average forward current	δ < 0.5; f = 20 kHz; $T_{amb} \le 100$ °C; square wave	[1]	-	-	0.5	А
		δ = 0.5; f = 20 kHz; $T_{sp} \le$ 140 °C; square wave		-	-	0.5	А
V _R	reverse voltage	T _j = 25 °C		-	-	40	V
V _F	forward voltage	I_F = 10 mA; pulsed; $t_p \le 300$ μs; $δ \le 0.02$; T_j = 25 °C		-	250	[tbd]	mV
I _R	reverse current	V _R = 10 V; T _j = 25 °C		-	3	[tbd]	μΑ
t _{rr}	reverse recovery time	I_R = 500 mA; I_F = 500 mA; $I_{R(meas)}$ = 100 mA; T_j = 25 °C		-	1.25	-	ns





[1] Device mounted on a ceramic Printed-Circuit Board (PCB), Al₂O₃, standard footprint.

Pinning information

Table 2. **Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode[1]		1 - 2
2	Α	anode		sym001
			Transparent top view	
			DSN0603-2 (SOD962-2)	

^[1] The marking bar indicates the cathode.

Ordering information

Table 3. **Ordering information**

Type number	Package					
	Name	Description	Version			
PMEG4005AESF	DSN0603-2	Leadless ultra small package; 2 terminals; body 0.6 x 0.3 x 0.3 mm	SOD962-2			

Marking 7.

Table 4. Marking codes

Type number	Marking code
PMEG4005AESF	N

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_R	reverse voltage	T _j = 25 °C		-	40	V
I _F	forward current	T _{sp} ≤ 138 °C		-	0.71	Α
I _{F(AV)}	average forward current	δ < 0.5; f = 20 kHz; $T_{amb} \le 100$ °C; square wave	[1]	-	0.5	А
		δ = 0.5; f = 20 kHz; T _{sp} ≤ 140 °C; square wave		-	0.5	A
I _{FRM}	repetitive peak forward current	$t_p = 1 \text{ ms}; \delta = 0.25$		-	1.2	Α
I _{FSM}	non-repetitive peak forward current	t_p = 8 ms; $T_{j(init)}$ = 25 °C; square wave		-	3.5	Α
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[2]	-	405	mW
			[3]	-	660	mW
			[1]	-	1200	mW
Tj	junction temperature			-	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C

- [1] Device mounted on a ceramic Printed-Circuit Board (PCB), Al₂O₃, standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for anode and cathode 1 cm² each.

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
uit a)	thermal resistance		[1][2]	-	-	310	K/W
	from junction to		[1][3]	-	-	190	K/W
	ambient		[1][4]	-	-	105	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		[5]	-	-	40	K/W

- [1] For Schottky barrier diodes thermal runaway has to be considered, as in some applications the reverse power losses P_R are a significant part of the total power losses.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for anode and cathode 1 cm² each.
- [4] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.
- [5] Soldering point of cathode tab.

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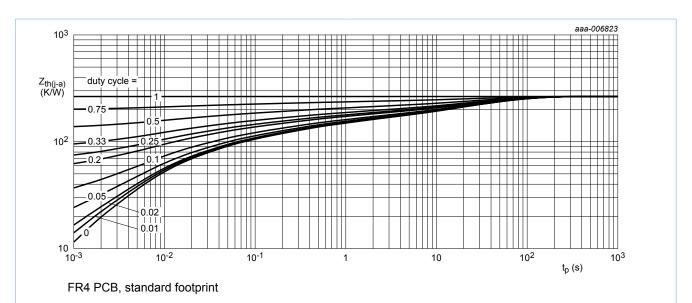
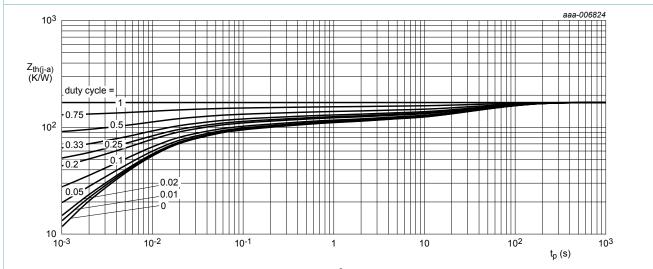
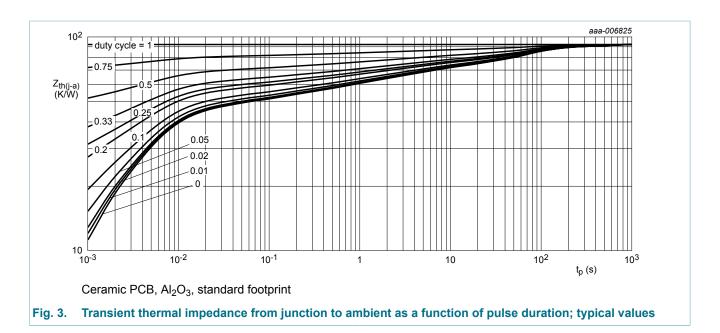


Fig. 1. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for anode and cathode 1 cm^2 each

Fig. 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

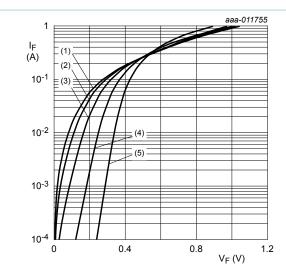


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10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
V _F forward voltage	forward voltage	I_F = 0.1 mA; t_p ≤ 300 μs; δ ≤ 0.02; T_j = 25 °C; pulsed	-	120	[tbd]	mV	
		I_F = 1 mA; pulsed; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C	-	180	[tbd]	mV	
		I_F = 10 mA; pulsed; $t_p \le 300$ μs; $δ \le 0.02$; T_j = 25 °C	-	250	[tbd]	mV	
		I_F = 100 mA; t_p ≤ 300 μs; δ ≤ 0.02; T_j = 25 °C	-	370	[tbd]	mV	
			I _F = 200 mA; pulsed; t _p ≤ 300 μs; δ ≤ 0.02; T _j = 25 °C	-	450	[tbd]	mV
		I_F = 300 mA; pulsed; $t_p \le$ 300 μs; $δ \le$ 0.02; T_j = 25 °C	-	530	[tbd]	mV	
		I_F = 400 mA; pulsed; $t_p \le 300$ μs; $δ \le 0.02$; T_j = 25 °C	-	600	[tbd]	mV	
		I_F = 500 mA; pulsed; $t_p \le 300$ μs; $\delta \le 0.02$; T_j = 25 °C	-	675	[tbd]	mV	
I _R	reverse current	V _R = 10 V; T _j = 25 °C	-	3	[tbd]	μΑ	
		V _R = 40 V; T _j = 25 °C	-	13	[tbd]	μΑ	
C _d	diode capacitance	V _R = 1 V; f = 1 MHz; T _j = 25 °C	-	18	-	pF	
		V _R = 10 V; f = 1 MHz; T _j = 25 °C	-	7	-	pF	
t _{rr}	reverse recovery time	I_F = 500 mA; I_R = 500 mA; $I_{R(meas)}$ = 100 mA; T_j = 25 °C	-	1.25	-	ns	



(1)
$$T_i = 150 \, ^{\circ}C$$

(2)
$$T_i = 125 \, ^{\circ}C$$

(3)
$$T_i = 85 \, ^{\circ}C$$

(4)
$$T_i = 25 \, ^{\circ}C$$

(5)
$$T_i = -40 \, ^{\circ}\text{C}$$

Fig. 4. Forward current as a function of forward voltage; typical values

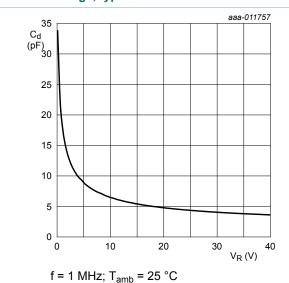
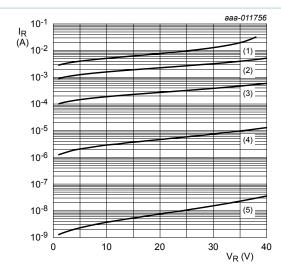


Fig. 6. Diode capacitance as a function of reverse voltage; typical values



(1)
$$T_i = 150 \, ^{\circ}C$$

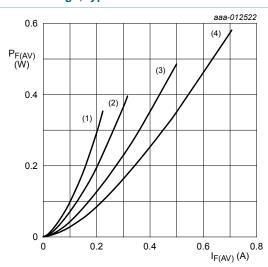
(2)
$$T_j = 125 \,^{\circ}\text{C}$$

(3)
$$T_i = 85 \, ^{\circ}C$$

(4)
$$T_i = 25$$
 °C

(5)
$$T_i = -40 \, ^{\circ}C$$

Fig. 5. Reverse current as a function of reverse voltage; typical values



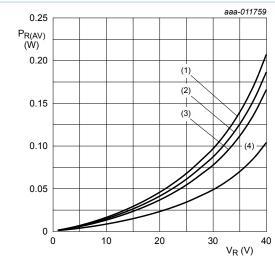
$$(1) \delta = 0.1$$

$$(2) \delta = 0.2$$

$$(3) \delta = 0.5$$

$$(4) \delta = 1$$

Fig. 7. Average forward power dissipation as a function of average forward current; typical values



 $T_i = 125 \,{}^{\circ}\text{C}$

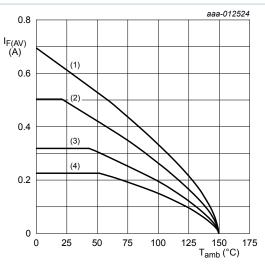
 $(1) \delta = 1$

 $(2) \delta = 0.9$

 $(3) \delta = 0.8$

 $(4) \delta = 0.5$

Average reverse power dissipation as a Fig. 8. function of reverse voltage; typical values



FR4 PCB, standard footprint

 $T_i = 150 \,{}^{\circ}\text{C}$

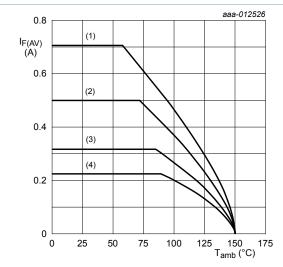
(1) δ = 1; DC

(2) $\delta = 0.5$; f = 20 kHz

(3) δ = 0.2; f = 20 kHz

(4) $\delta = 0.1$; f = 20 kHz

Fig. 9. Average forward current as a function of ambient temperature; typical values



FR4 PCB, mounting pad for anode and cathode 1 cm² each

 $T_i = 150 \, ^{\circ}C$

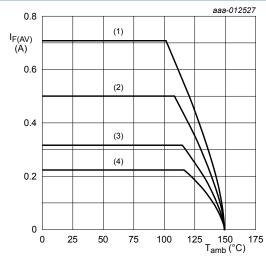
(1) δ = 1; DC

(2) $\delta = 0.5$; f = 20 kHz

(3) $\delta = 0.2$; f = 20 kHz

(4) δ = 0.1; f = 20 kHz

Fig. 10. Average forward current as a function of solder point temperature; typical values



Ceramic PCB, Al₂O₃, standard footprint

 $T_i = 150 \,{}^{\circ}\text{C}$

(1) δ = 1; DC

(2) $\delta = 0.5$; f = 20 kHz

(3) δ = 0.2; f = 20 kHz

(4) $\delta = 0.1$; f = 20 kHz

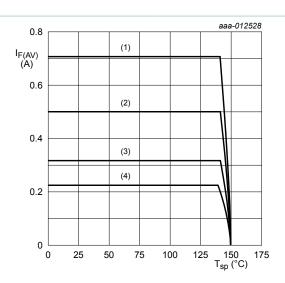
Fig. 11. Average forward current as a function of ambient temperature; typical values

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T_j = 150 °C

(1) δ = 1; DC

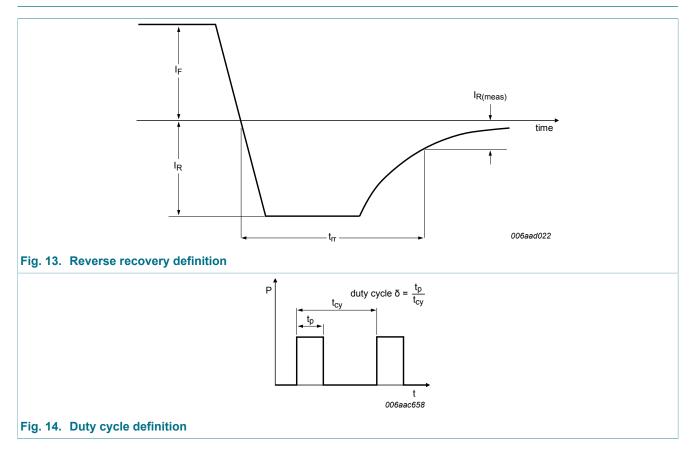
(2) δ = 0.5; f = 20 kHz

(3) δ = 0.2; f = 20 kHz

(4) δ = 0.1; f = 20 kHz

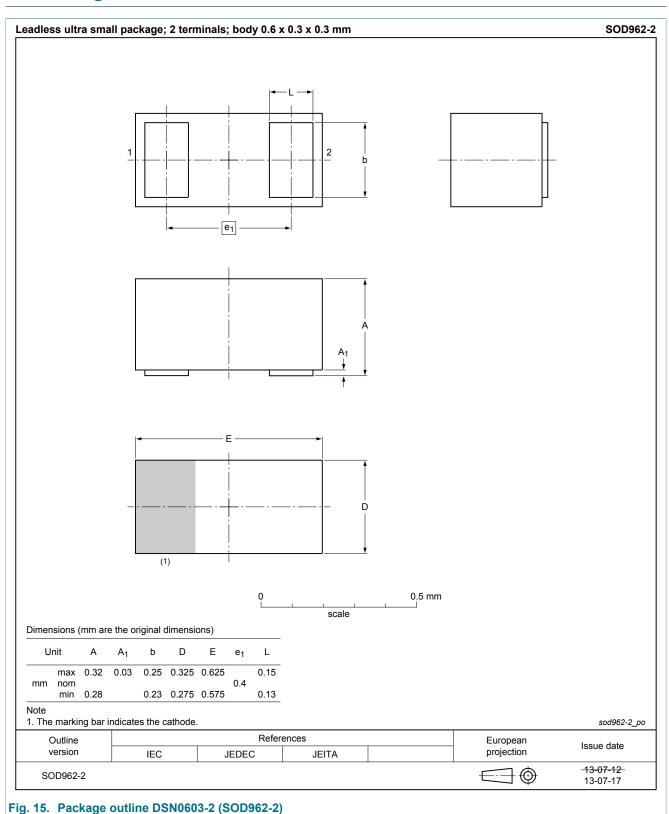
Fig. 12. Average forward current as a function of solder point temperature; typical values

11. Test information



The current ratings for the typical waveforms are calculated according to the equations: $I_{F(AV)} = I_M \times \delta$ with I_M defined as peak current, $I_{RMS} = I_{F(AV)}$ at DC, and $I_{RMS} = I_M \times \sqrt{\delta}$ with I_{RMS} defined as RMS current.

12. Package outline

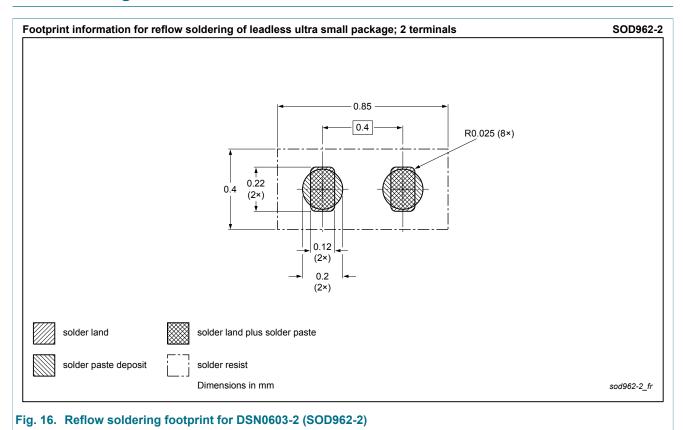


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13. Soldering



14. Revision history

Table 8. Revision history

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
PMEG4005AESF v.1	20140507	Preliminary data sheet	-	-

15. Legal information

15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
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